

<b>Notice of References Cited</b>	Application/Control No. 10/055,278	Applicant(s)/Patent Under Reexamination BAWELL ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,396,362	05-2002	Mourant et al.	333/25
*	B	US-5,781,071	07-1998	Kusunoki, Shigeo	330/269
*	C	US-5,214,796	05-1993	Gorrie et al.	455/326
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
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	T					

**NON-PATENT DOCUMENTS**

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	X	

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,929,729	07-1999	Swarup, Arvind	333/246
	B	US-5,463,355	10-1995	Halloran, Timothy	332/103
	C	US-4,914,407	04-1990	Itoh, Tatsuo	333/161
	D	US-4,511,813	04-1985	Pan, Jing-Jong	327/431
	E	US-3,999,150	12-1976	Caragliano et al.	333/116
	F	US-3,988,705	10-1976	Drapac, Michael J.	333/109
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Boylestad, Introductory Circuit Analysis, Merrill, 4 <sup>th</sup> Edition, pages 227-230.
	V	
	W	
	X	

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